



PRELIMINARY

SOLID STATE DEVICES, INC

14849 Firestone Boulevard · La Mirada, CA 90638  
Phone: (714) 670-SSDI (7734) · Fax: (714) 522-7424

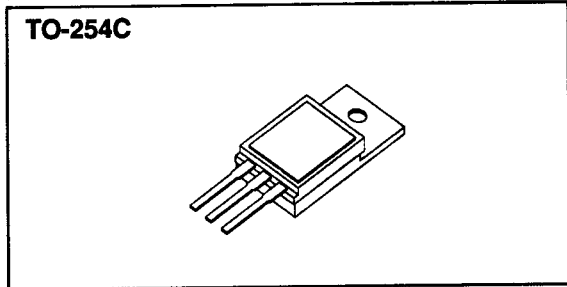
**SFF450C**

**13 AMP  
500 VOLTS  
0.40Ω  
N-CHANNEL  
POWER MOSFET**

**Designer's Data Sheet**

**FEATURES:**

- Rugged construction with poly silicon gate
- Low RDS(on) and high transconductance
- Excellent high temperature stability
- Very fast switching speed
- Fast recovery and superior dv/dt performance
- Increased reverse energy capability
- Low input and transfer capacitance for easy paralleling
- Hermetically sealed power package
- Low inductance leads
- TX, TXV and Space Level screening available
- Replaces: IRF450 Types



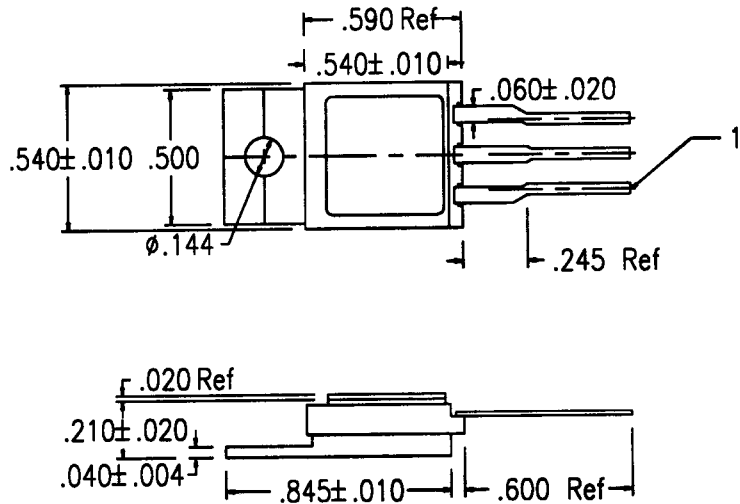
**MAXIMUM RATINGS**

CHARACTERISTIC	SYMBOL	VALUE	UNIT
Drain to Source Voltage	V <sub>DS</sub>	500	Volts
Gate to Source Voltage	V <sub>GS</sub>	±20	Volts
Continuous Drain Current	I <sub>D</sub>	13	Amps
Operating and Storage Temperature	T <sub>OP</sub> & T <sub>STG</sub>	-55 to +150	°C
Thermal Resistance, Junction to Case	R <sub>θJC</sub>	1.0	°C/W
Total Device Dissipation @ TC=25°C Total Device Dissipation @ TC=55°C	P <sub>D</sub>	125 95	Watts

**PACKAGE OUTLINE: CERAMIC TO-254**

**PIN OUT:**

- PIN 1: DRAIN**
- PIN 2: SOURCE**
- PIN 3: GATE**



**NOTE:** All specifications are subject to change without notification. SCD's for these devices should be reviewed by SSDI prior to release.

**DATA SHEET #: F00101 A**

**MED**

**SFF450C**

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**ELECTRICAL CHARACTERISTICS @ T<sub>J</sub>=25 °C (Unless Otherwise Specified)**

RATING		SYMBOL	MIN	TYP	MAX	UNIT
Drain to Source Breakdown Voltage (VGS=0 V, ID=250μA)		BV <sub>DSS</sub>	500	---	---	V
Drain to Source on State Resistance (VGS=10 V, ID=7.2 A)		R <sub>DS(on)</sub>	---	0.35	0.40	Ω
On State Drain Current (V <sub>DS</sub> > ID(on) X R <sub>DS(on)</sub> Max, VGS=10 V)		I <sub>D(on)</sub>	13	---	---	A
Gate Threshold Voltage (V <sub>DS</sub> =VGS, I <sub>D</sub> =250μA)		VGS(th)	2.0	---	4.0	V
Forward Transconductance (V <sub>DS</sub> ≥ 50 V, I <sub>DS</sub> =7.2 A)		g <sub>fs</sub>	8.7	13	---	S(Ω)
Zero Gate Voltage Drain Current (V <sub>DS</sub> =max rated voltage, VGS=0 V) (V <sub>DS</sub> =80% rated V <sub>DS</sub> , VGS=0 V, T <sub>A</sub> =125°C)		I <sub>DSS</sub>	---	---	250 1000	μA
Gate to Source Leakage Forward Gate to Source Leakage Reverse	At rated VGS	I <sub>GSS</sub>	---	---	100 -100	nA
Total Gate Charge Gate to Source Charge Gate to Drain Charge	VGS=10 Volts 80% rated V <sub>DS</sub> Rated I <sub>D</sub>	Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	---	83 11 42	120 17 64	nC
Turn on Delay Time Rise Time Turn Off Delay Time Fall Time	V <sub>DD</sub> =50% rated V <sub>DS</sub> 50% rated I <sub>D</sub> R <sub>G</sub> = 6.2 Ω R <sub>D</sub> =20W	t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	---	18 44 70 40	27 66 100 60	nsec
Diode Forward Voltage (I <sub>S</sub> =rated I <sub>D</sub> , VGS=0 V, T <sub>J</sub> =25°C)		V <sub>SD</sub>	---	---	1.4	V
Diode Reverse Recovery Time Reverse Recovery Charge	T <sub>J</sub> =25°C I <sub>F</sub> =rated I <sub>D</sub> di/dt=100 A/μsec	t <sub>rr</sub> Q <sub>RR</sub>	280 3.2 ---	580 6.7	1200 14	nsec μC
Input Capacitance Output Capacitance Reverse Transfer Capacitance	VGS=0 Volts V <sub>DS</sub> =25 Volts f= 1 MHz	C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	---	2700 350 75	---	pF

For thermal derating curves and other characteristic curves please contact SSDI Marketing Department.